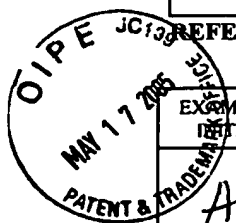


FORM PTO-1449	ATTY. DKT NO.	11-207	SER. NO.	10/716,795
	APPLICANT	Samukawa et al.		
	FILING DATE	November 20, 2003	GROUP	2636



REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
AL	5,731,779 (English counterpart of JP A-H09-178856)	Mar. 24, 1998	Kikuchi	342	70
AL	6,597,307 (English counterpart of JP A-2002-257926)	Jul. 22, 2003	Nakanishi et al.	342	70
AL	6,061,001 (English counterpart of JP A-2000-56020)	May 9, 2000	Sugimoto	340	903
AL	2004/0065814 (English counterpart of JP A-2004-125739)	Apr. 8, 2004	Miyazaki et al.	256	222.1
AL	2002/0189875 (English counterpart of JP-A-2002-202360)	Dec. 19, 2002	Asanuma et al.	180	169

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TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
									Eng. Abstract
AL	JP-A-H09-178856 (Counterpart of US5,731,779)	7/11/97	Japan	Kikuchi	_____	_____		X	
AL	JP-A-2002-174684	6/21/02	Japan	Matsuda	_____	_____			X
AL	JP-2002-257926 (Counterpart of US6,597,307)	9/11/02	Japan	Moti	_____	_____		X	
AL	JP-A-2000-56020 (Counterpart of US6,061,001)	2/25/00	Japan	Yogichi	_____	_____		X	
AL	JP-A-2004-125739 (Counterpart of US 2004/0065814)	4/22/04	Japan	Uidemori	_____	_____		X	
AL	JP-A-2003-107159	4/9/03	Japan	Kikuchi	_____	_____			X
AL	JP-A-2002-202360	7/19/02	Japan	Asanuma	_____	_____		X	
AL	JP-A-2001-21646	1/26/01	Japan	Kishida	_____	_____			X

* Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED
Anh La	6/17/05